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**SHEET 1 OF 1**

## INFORMATION DISCLOSURE STATEMENT

APPLICANT  
Emiko Nishida, et al.

**FILING DATE**  
**June 25, 2001**

GROUP  
1711

## U.S. PATENT DOCUMENTS

[illegible]

## FOREIGN PATENT DOCUMENTS

[illegible]

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

W		Grèzes-Besset, et al., "Synthesis and research of the optimum conditions for the optical monitoring of non-quarter-wave multilayers," Applied Optics, Optical Society of America, Wash. US, vol 32, no 28, 10/1/93, pp..5612-5618
W		S. Callard, et al., "New method for in situ control of Bragg reflector fabrication," Applied Physics Letters, American Institute of Physics, New York, US, vol. 68, no. 17, April 22, 1996, pages 2335-2336
W		M. Kildemo, et al., "A direct robust feedback method for growth control of optical coatings by multiwavelength ellipsometry," Thin Solid Films, Elsevier-Sequoia S.A. Lausanne, CH, vol. 313-314, Feb. 13, 1998, pages 484-489

**EXAMINER**

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